# MOSFET – Power, N-Channel, Logic Level 100 V, 25 A, 50 mΩ

## NVD6495NL

#### **Features**

- Low R<sub>DS(on)</sub>
- 100% Avalanche Tested
- AEC-Q101 Qualified
- These Devices are Pb-Free and are RoHS Compliant

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	100	V
Gate-to-Source Voltage - Continuous			V <sub>GS</sub>	± 20	V
Continuous Drain	Steady State	T <sub>C</sub> = 25°C	I <sub>D</sub>	25	Α
Current		T <sub>C</sub> = 100°C		18	
Power Dissipation	Steady State	T <sub>C</sub> = 25°C	P <sub>D</sub>	83	W
Pulsed Drain Current	t <sub>p</sub> = 10 μs		I <sub>DM</sub>	80	Α
Operating and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Source Current (Body Diode)			I <sub>S</sub>	25	Α
Single Pulse Drain-to-Source Avalanche Energy ( $V_{DD}$ = 50 Vdc, $V_{GS}$ = 10 Vdc, $I_{L(pk)}$ = 23 A, L = 0.3 mH, $R_{G}$ = 25 $\Omega$ )			E <sub>AS</sub>	79	mJ
Lead Temperature for Soldering Purposes, 1/8" from Case for 10 Seconds			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case (Drain) - Steady State	$R_{\theta JC}$	1.8	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	49	

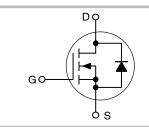
Surface mounted on FR4 board using 1 sq in pad size, (Cu Area 1.127 sq in [2 oz] including traces).



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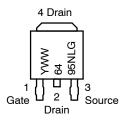
V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
100 V	54 mΩ @ 4.5 V	25 A
	50 m $\Omega$ @ 10 V	237





DPAK CASE 369AA STYLE 2

# MARKING DIAGRAM & PIN ASSIGNMENT



6495NL = Device Code
Y = Year
WW = Work Week
G = Pb-Free Package

#### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_D$ = 250 $\mu A$ $V_{GS}$ = 0 V, $I_D$ = 250 $\mu A$ , $T_J$ = -40°C	100 92			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>			115		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 \text{ V},$ $V_{DS} = 100 \text{ V}$ $T_{J} = 25^{\circ}\text{C}$			1.0	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			±100	nA
ON CHARACTERISTICS (Note 2)	ı					
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.0		2.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>			4.8		mV/°C
Drain-to-Source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 10 A		44	54	mΩ
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A		43	50	
Forward Transconductance	9FS	V <sub>DS</sub> = 5.0 V, I <sub>D</sub> = 10 A		24		S
CHARGES, CAPACITANCES AND GAT	TE RESISTANO	CE CE				
Input Capacitance	C <sub>ISS</sub>			1024		pF
Output Capacitance	Coss	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz, V}_{DS} = 25 \text{ V}$	,	156		1
Reverse Transfer Capacitance	C <sub>RSS</sub>			70		
Total Gate Charge	Q <sub>G(TOT)</sub>			20		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>			1.1		
Gate-to-Source Charge	$Q_{GS}$	$V_{GS} = 4.5 \text{ V}, V_{DS} = 80 \text{ V}, I_{D} = 23 \text{ A}$		3.1		
Gate-to-Drain Charge	$Q_{GD}$			14		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = 10 \text{ V}, V_{DS} = 80 \text{ V}, I_D = 23 \text{ A}$		35		nC
SWITCHING CHARACTERISTICS (Not	e 3)					
Turn-On Delay Time	t <sub>d(on)</sub>			11		ns
Rise Time	t <sub>r</sub>	$V_{GS} = 4.5 \text{ V}, V_{DD} = 80 \text{ V},$		91		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D = 23 \text{ A}, R_G = 6.1 \Omega$		40		
Fall Time	t <sub>f</sub>			71		
DRAIN-SOURCE DIODE CHARACTER	RISTICS				•	
Forward Diode Voltage	$V_{SD}$	$V_{GS} = 0 \text{ V}, I_S = 23 \text{ A}$ $T_J = 25^{\circ}\text{C}$ $T_J = 125^{\circ}\text{C}$		0.87	1.2	V
Reverse Recovery Time	t <sub>RR</sub>	., 120 (		64		ns
Charge Time	T <sub>a</sub>	\\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \		40		1
Discharge Time	T <sub>b</sub>	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 23 \text{ A}$		24		1
Reverse Recovery Charge	Q <sub>RR</sub>			152	-	nC
1.0.0.00 1.000 vory Onlargo	≺HH			102	<u> </u>	,10

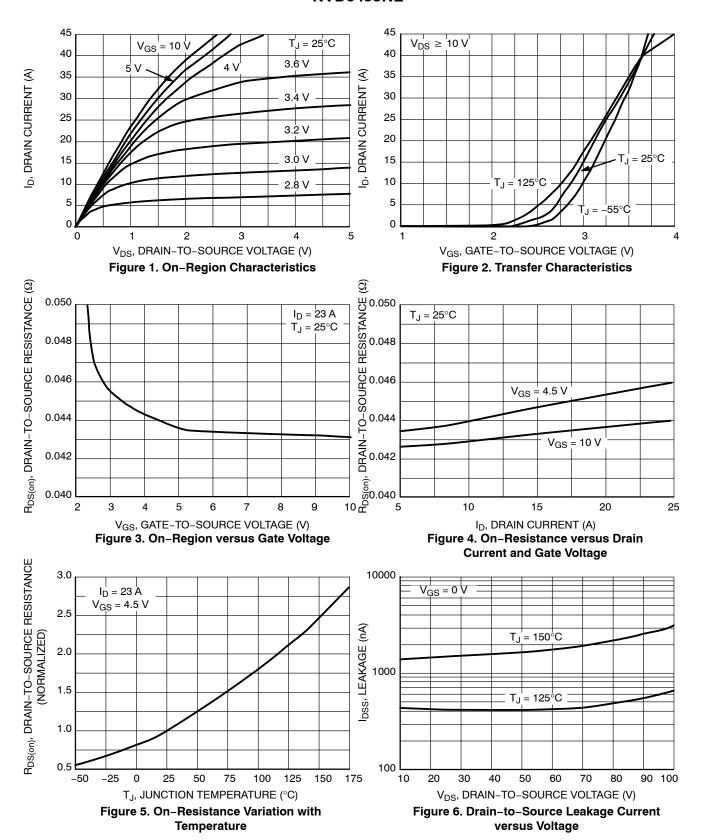
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 2. Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2%.

### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NVD6495NLT4G	DPAK (Pb-Free)	2500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

<sup>3.</sup> Switching characteristics are independent of operating junction temperatures.



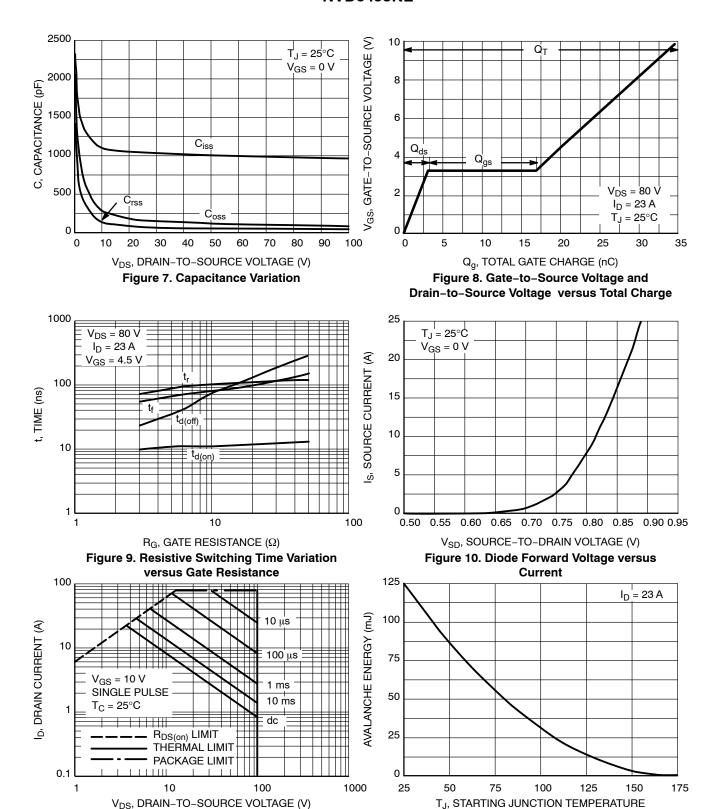


Figure 12. Maximum Avalanche Energy versus

**Starting Junction Temperature** 

Figure 11. Maximum Rated Forward Biased

Safe Operating Area

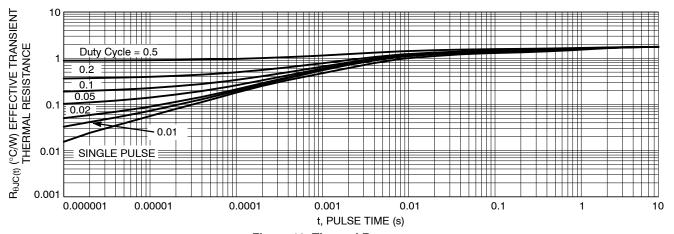


Figure 13. Thermal Response

STYLE 1: PIN 1. BASE

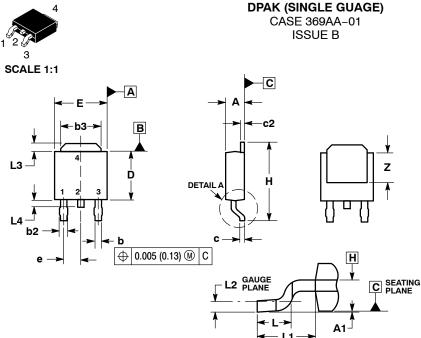
STYLE 5:

2. COLLECTOR 3. EMITTER

4. COLLECTOR

PIN 1. GATE 2. ANODE 3. CATHODE

4. ANODE



STYLE 3: PIN 1. ANODE

STYLE 7:

2. CATHODE 3. ANODE

PIN 1. GATE 2. COLLECTOR

3. EMITTER

COLLECTOR

CATHODE

**DETAIL A** ROTATED 90° CW

STYLE 4: PIN 1. CATHODE 2. ANODE 3. GATE



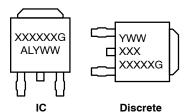
**DATE 03 JUN 2010** 

#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: INCHES.
  3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
  4. DIMENSIONS D AND E DO NOT INCLUDE MOLD
- FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
Е	0.250	0.265	6.35	6.73
е	0.090 BSC		2.29 BSC	
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108 REF		2.74	REF
L2	0.020 BSC		0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

#### **GENERIC** MARKING DIAGRAM\*



XXXXXX = Device Code Α = Assembly Location L = Wafer Lot ٧ = Year = Work Week WW = Pb-Free Package

# **SOLDERING FOOTPRINT\***

3. GATE

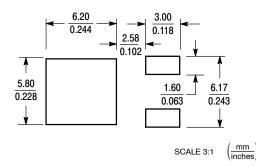
STYLE 2: PIN 1. GATE

STYLE 6:

PIN 1. MT1 2. MT2

2. DRAIN 3. SOURCE

4. DRAIN



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	DPAK (SINGLE GAUGE)		PAGE 1 OF 1	

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